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AI for Wireless Communications and Security

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Deadline for manuscript submissions:

15 January 2025

Message from the Guest Editors

Dear Colleagues,

Al has transformed many areas, including that of wireless communication. It has significantly improved the performance of wireless system design, wireless sensing, and wireless security. In collaboration with CyberC 2024, this Special Issue aims to promote discussion on fundamental and practically relevant questions related to the challenges arising from deep learning in wireless communications, sensing, and security. We seek to publish studies pertaining, but not limited to, advances in Al/ML and deep learning in relation to the following:

- wireless networks
- A1
- deep learning
- 5/6G
- communications
- security

We look forward to receiving your contributions.

Dr. Bin Xie Prof. Dr. Anup Kumar Guest Editors











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Editor-in-Chief

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Message from the Editor-in-Chief

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